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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/735,631	LEE, SANG-HYUB	
Examiner	Art Unit	

Mark Blouin

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	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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Search Closs 369, 369, 720 Ju EAST Sunch	3/26/07	rz	
Text Sand 369,360, 720 See EAST Surh	3/26/07	ws	
Searland Double Patents Tur / Assymu / Carhanha	3/24/07	мп	
Consulted w/ P.E. Bill Klumwicz	3/22/07	vos	